Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/806,338	OHASHI ET AL.	
Examiner	Art Unit	
David E. Martinez	2181	

	SEARCHED					
Class	Subclass	Date	Examiner			
710	36	1/16/2007	DM			
	·	·				
·						
·						

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	1				
	·				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East see attached	1/19/2007	DM ·	
710/36-38.ccls. 714/1-4.ccls. with keywords and text search	1/19/2007	DM	
eDan inventor search	1/19/2007	DM	
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	1/19/2007	DM	
		<i>:</i>	